Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/617,404	GORENFLO ET AL.	
Examiner	Art Unit	

Hwei-Siu C. Payer

3724

	SEAR	CHED	
Class	Subclass	Date	Examiner
173	162.1	3-21-06	Pager
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	211		
	211		

INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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